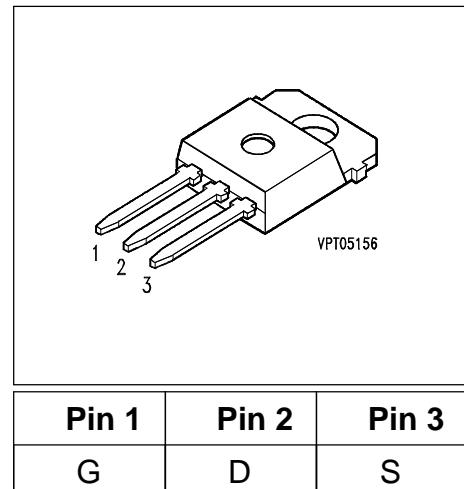


SIPMOS® Power Transistor

- N channel
- Enhancement mode
- FREDFET



Type	V _{DS}	I _D	R _{DS(on)}	Package	Ordering Code
BUZ 384	500 V	10.5 A	0.6 Ω	TO-218 AA	C67078-A3209-A2

Maximum Ratings

Parameter	Symbol	Values	Unit
Drain source voltage	V _{DS}	500	V
Drain-gate voltage	V _{DGR}		
R _{GS} = 20 kΩ		500	
Continuous drain current	I _D		A
T _C = 25 °C		10.5	
Pulsed drain current	I _{Dpuls}		
T _C = 25 °C		42	
Gate source voltage	V _{GS}	± 20	V
Power dissipation	P _{tot}		W
T _C = 25 °C		125	
Operating temperature	T _j	-55 ... + 150	°C
Storage temperature	T _{stg}	-55 ... + 150	
Thermal resistance, chip case	R _{thJC}	≤ 1	K/W
Thermal resistance, chip to ambient	R _{thJA}	75	
DIN humidity category, DIN 40 040		E	
IEC climatic category, DIN IEC 68-1		55 / 150 / 56	

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Static Characteristics

Drain- source breakdown voltage $V_{GS} = 0 \text{ V}, I_D = 0.25 \text{ mA}, T_j = 25^\circ\text{C}$	$V_{(\text{BR})\text{DSS}}$	500	-	-	V
Gate threshold voltage $V_{GS}=V_{DS}, I_D = 1 \text{ mA}$	$V_{GS(\text{th})}$	2.1	3.5	4	
Zero gate voltage drain current $V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25^\circ\text{C}$ $V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 125^\circ\text{C}$	I_{DSS}	-	20	250	μA
Gate-source leakage current $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	I_{GSS}	-	10	100	nA
Drain-Source on-resistance $V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}$	$R_{\text{DS}(\text{on})}$	-	0.55	0.6	Ω

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Dynamic Characteristics

Transconductance $V_{DS} \geq 2 * I_D * R_{DS(on)max}$, $I_D = 6.5 \text{ A}$	g_{fs}	2.7	6.7	-	S
Input capacitance $V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1 \text{ MHz}$	C_{iss}	-	3800	4900	pF
Output capacitance $V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1 \text{ MHz}$	C_{oss}	-	250	400	
Reverse transfer capacitance $V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1 \text{ MHz}$	C_{rss}	-	100	170	
Turn-on delay time $V_{DD} = 30 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 2.8 \text{ A}$ $R_{GS} = 50 \Omega$	$t_{d(on)}$	-	50	75	ns
Rise time $V_{DD} = 30 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 2.8 \text{ A}$ $R_{GS} = 50 \Omega$	t_r	-	80	120	
Turn-off delay time $V_{DD} = 30 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 2.8 \text{ A}$ $R_{GS} = 50 \Omega$	$t_{d(off)}$	-	330	430	
Fall time $V_{DD} = 30 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 2.8 \text{ A}$ $R_{GS} = 50 \Omega$	t_f	-	110	140	

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

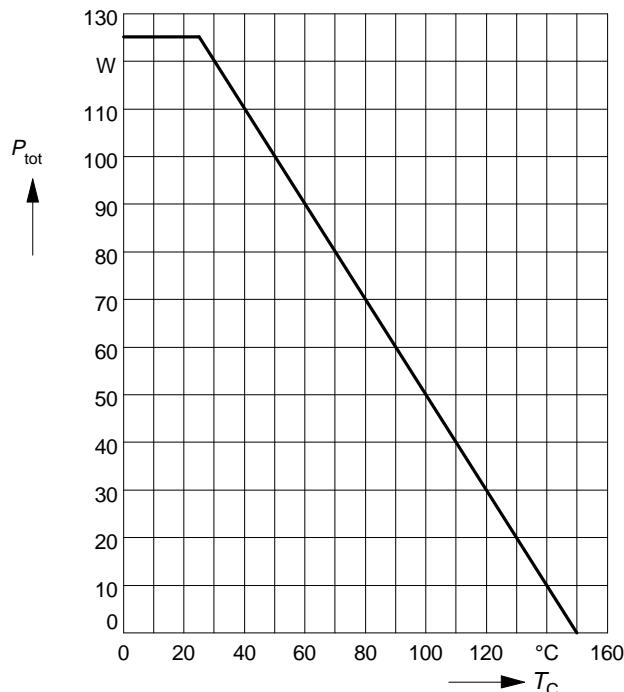
Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Reverse Diode

Inverse diode continuous forward current $T_C = 25^\circ\text{C}$	I_S	-	-	10.5	A
Inverse diode direct current,pulsed $T_C = 25^\circ\text{C}$	I_{SM}	-	-	42	
Inverse diode forward voltage $V_{GS} = 0 \text{ V}, I_F = 21 \text{ A}$	V_{SD}	-	1.3	1.7	V
Reverse recovery time $V_R = 100 \text{ V}, I_F=I_S, di_F/dt = 100 \text{ A}/\mu\text{s}$	t_{rr}	-	180	250	ns
Reverse recovery charge $V_R = 100 \text{ V}, I_F=I_S, di_F/dt = 100 \text{ A}/\mu\text{s}$	Q_{rr}	-	0.65	1.2	μC

Power dissipation

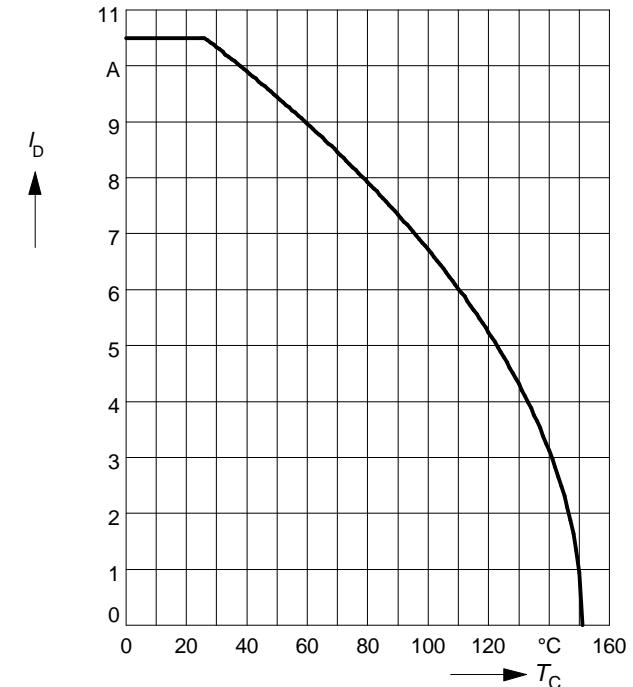
$$P_{\text{tot}} = f(T_C)$$



Drain current

$$I_D = f(T_C)$$

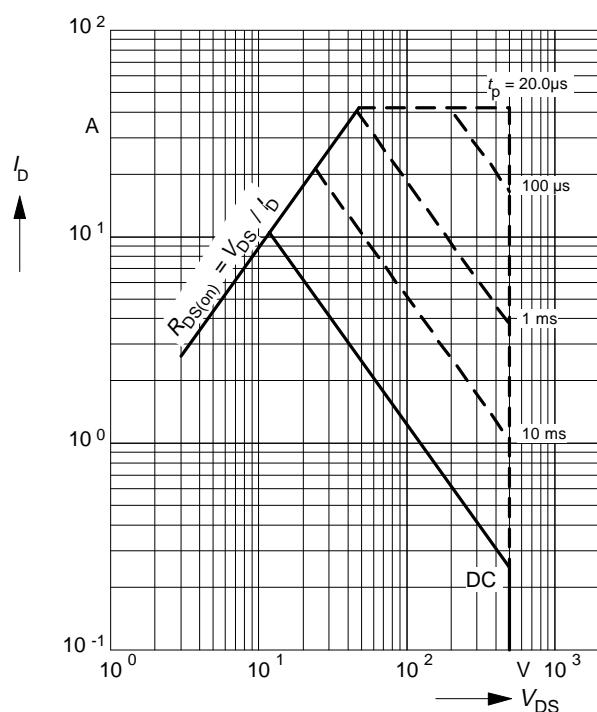
parameter: $V_{GS} \geq 10$ V



Safe operating area

$$I_D = f(V_{DS})$$

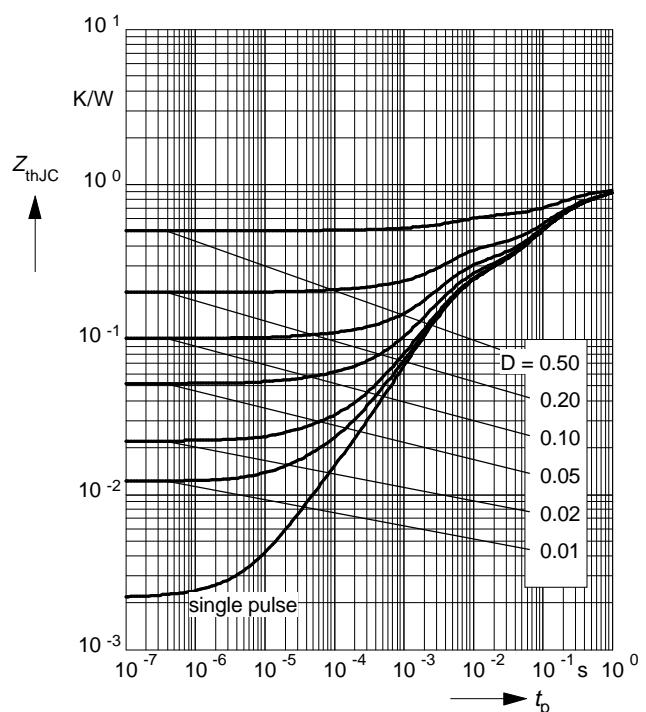
parameter: $D = 0.01$, $T_C = 25^\circ\text{C}$



Transient thermal impedance

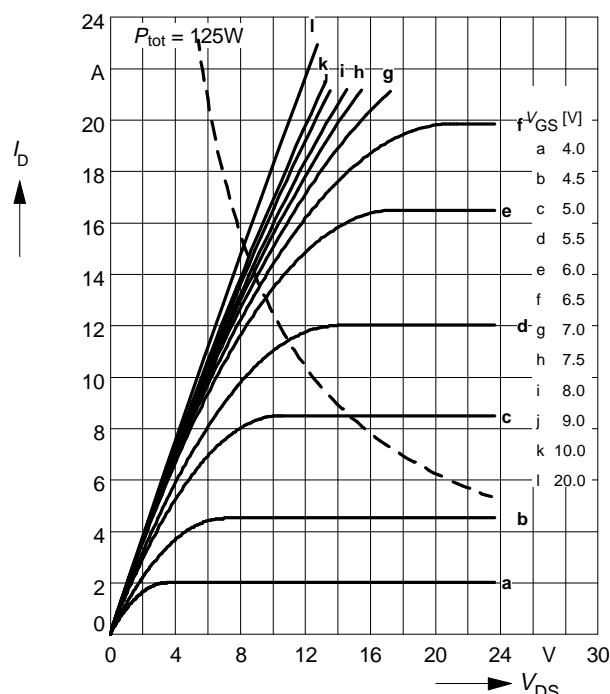
$$Z_{\text{th JC}} = f(t_p)$$

parameter: $D = t_p / T$



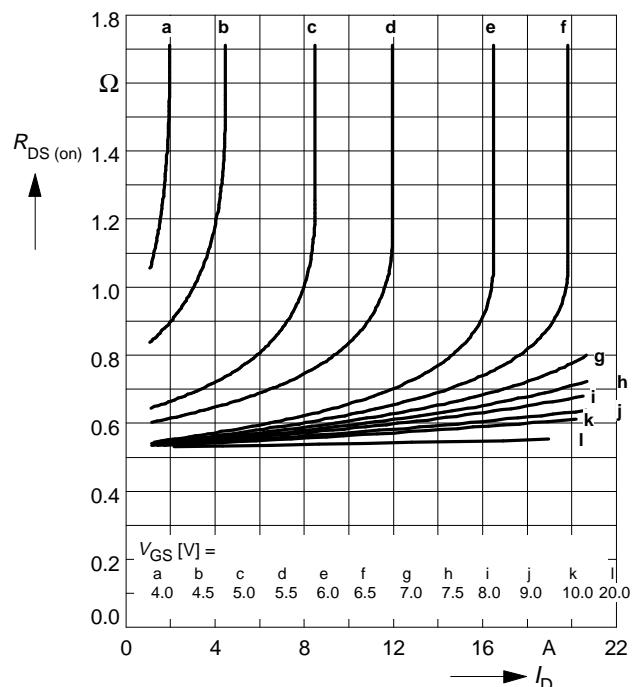
Typ. output characteristics $I_D = f(V_{DS})$

parameter: $t_p = 80 \mu s$



Typ. drain-source on-resistance $R_{DS(on)} = f(I_D)$

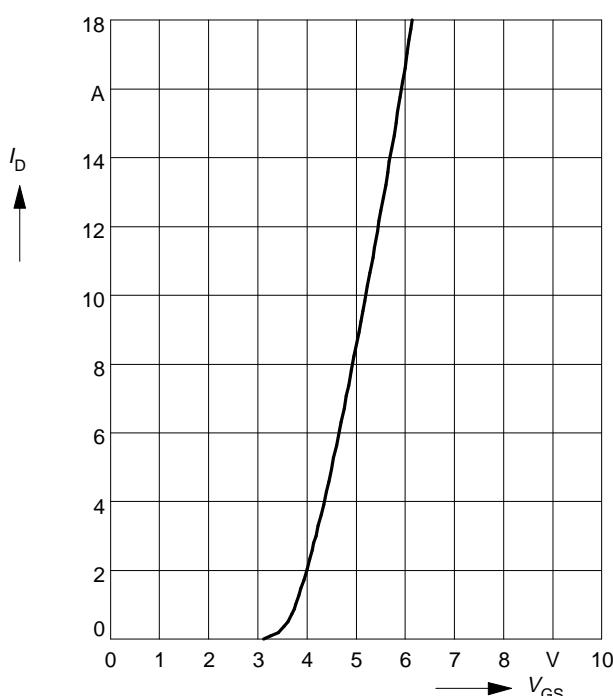
parameter: V_{GS}



Typ. transfer characteristics $I_D = f(V_{GS})$

parameter: $t_p = 80 \mu s$

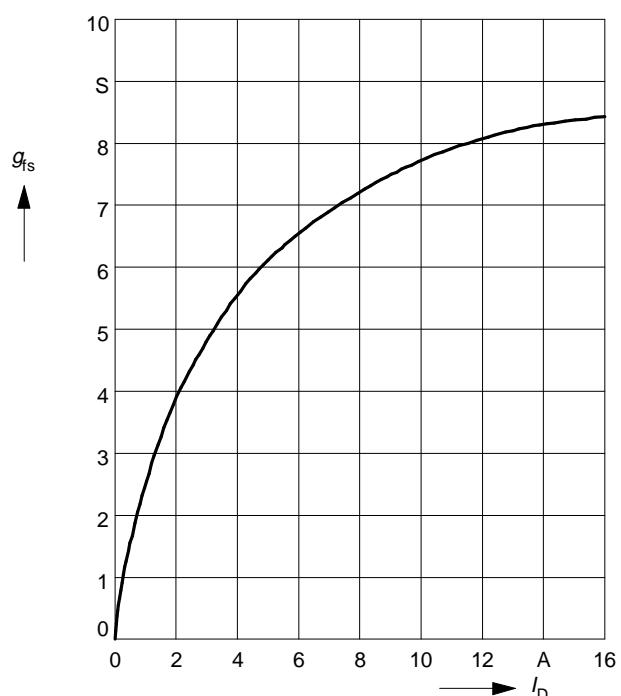
$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



Typ. forward transconductance $g_{fs} = f(I_D)$

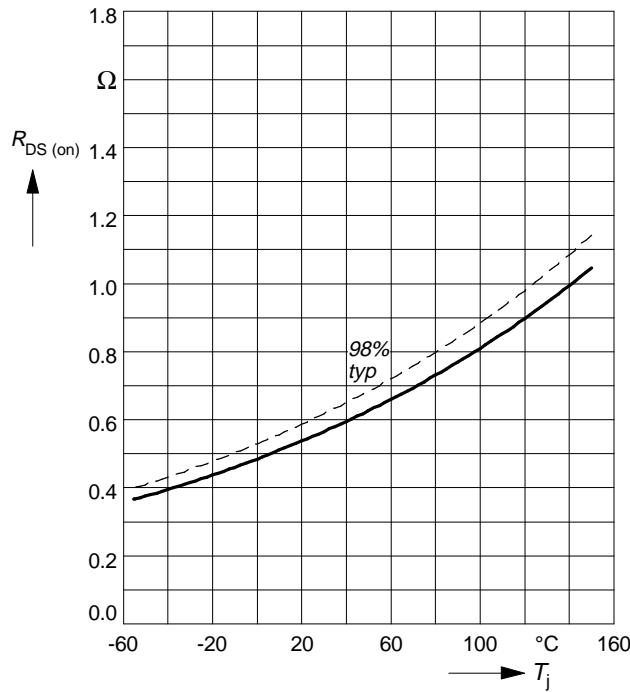
parameter: $t_p = 80 \mu s$,

$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



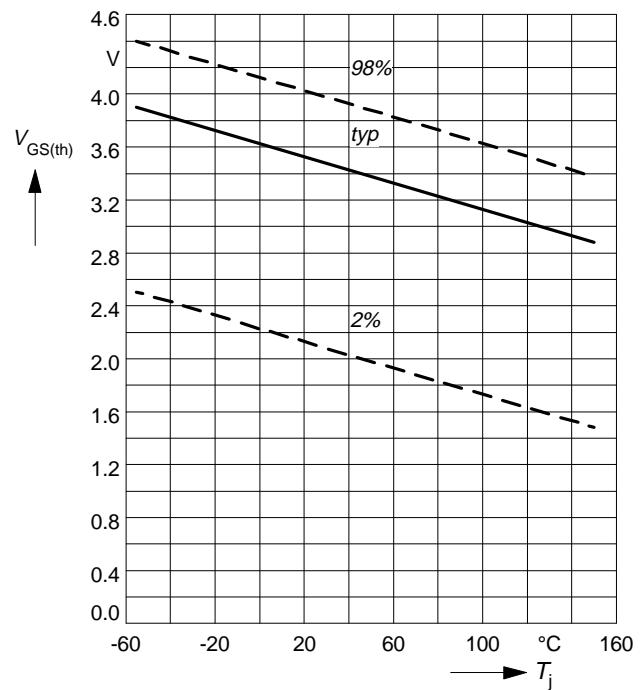
Drain-source on-resistance

$R_{DS(on)} = f(T_j)$
parameter: $I_D = 6.5 \text{ A}$, $V_{GS} = 10 \text{ V}$



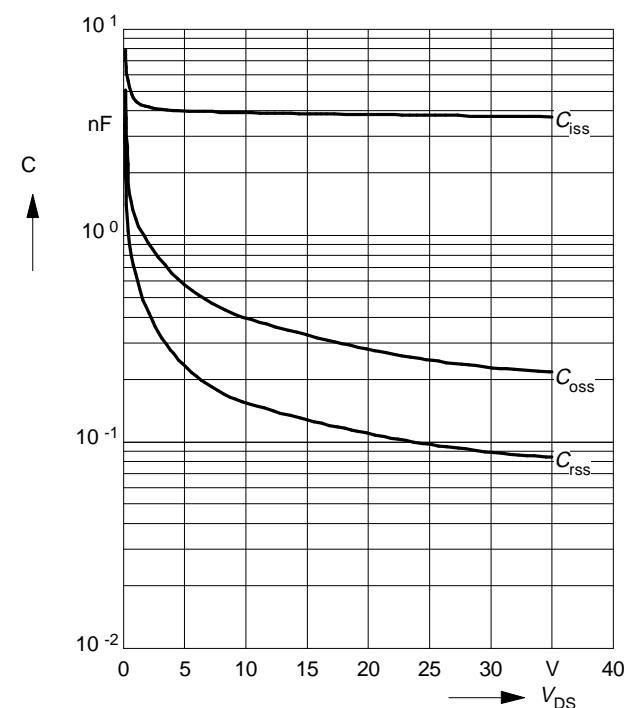
Gate threshold voltage

$V_{GS(th)} = f(T_j)$
parameter: $V_{GS} = V_{DS}$, $I_D = 1 \text{ mA}$



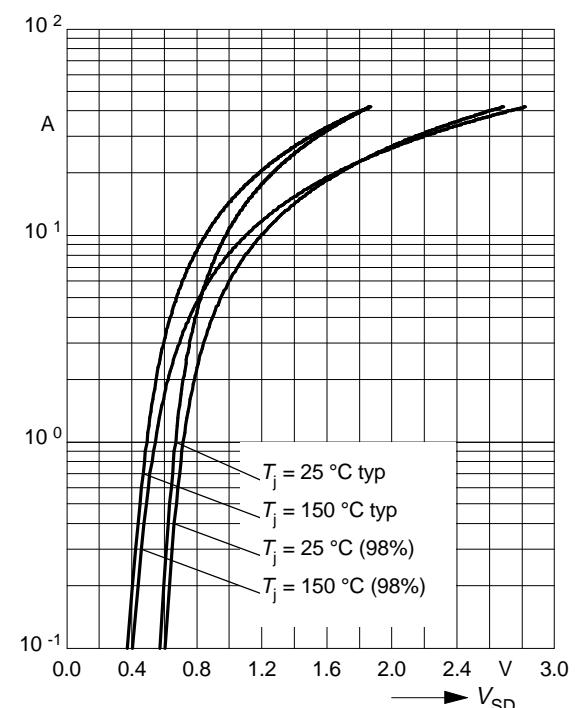
Typ. capacitances

$C = f(V_{DS})$
parameter: $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$



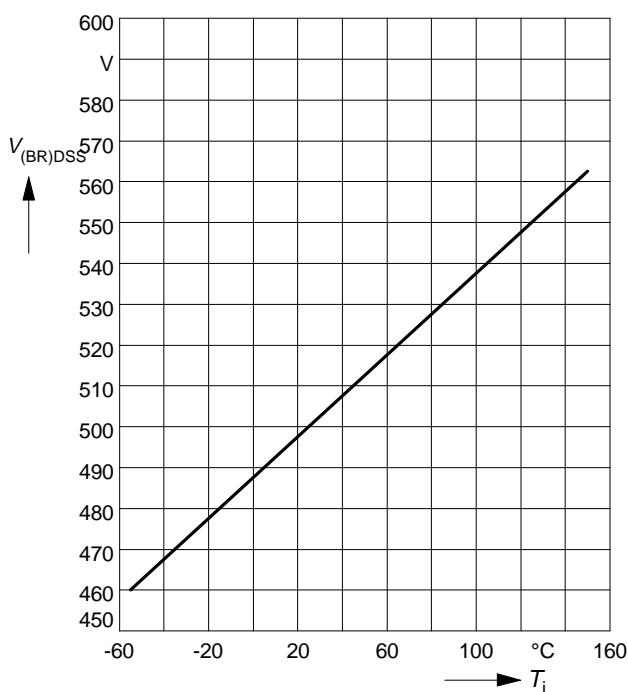
Forward characteristics of reverse diode

$I_F = f(V_{SD})$
parameter: T_j , $t_p = 80 \mu\text{s}$



Drain-source breakdown voltage

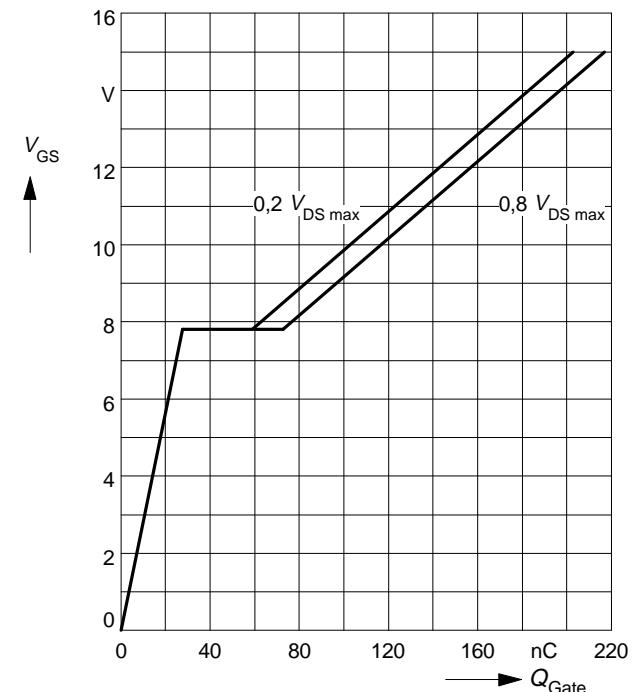
$$V_{(BR)DSS} = f(T_j)$$



Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

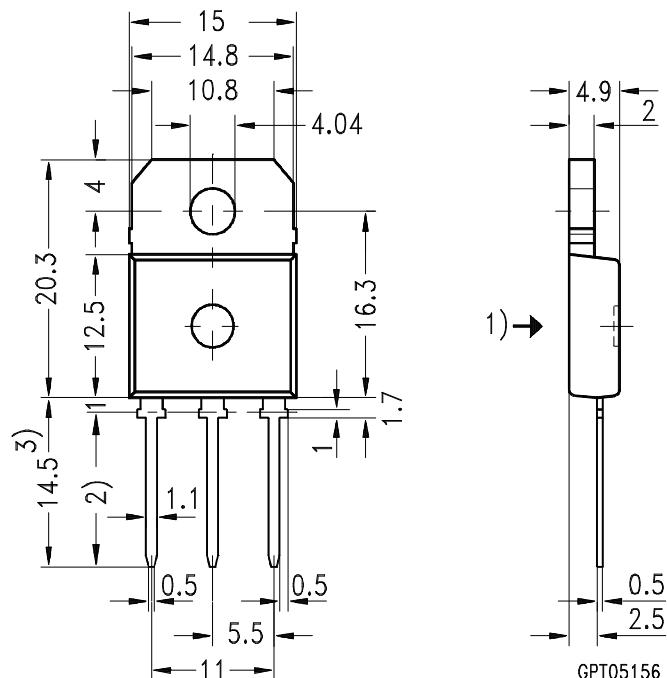
parameter: I_D puls = 14 A



Package Outlines

TO-218 AA

Dimension in mm



- 1) punch direction, burr max. 0.04
- 2) dip tinning
- 3) max. 15.5 by dip tinning press burr max. 0.05